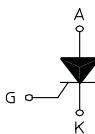


STANDARD SCR

TO220-F (FULLY ISOLATED CASE)  	On-State Current Gate Trigger Current 12 Amp 2 mA to 15 mA Off-State Voltage 200 V ÷ 800 V
	<p>These series of Silicon Controlled Rectifier use a high performance PNPN technology.</p> <p>These parts are intended for general purpose applications where high gate sensitivity is required.</p>

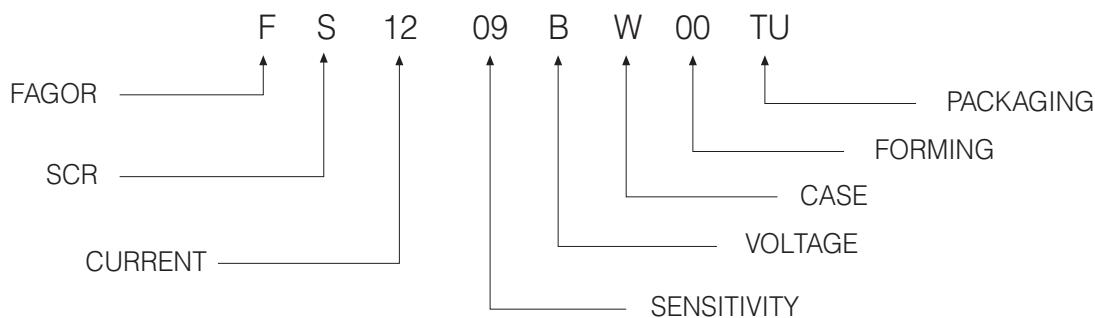
Absolute Maximum Ratings, according to IEC publication No. 134

SYMBOL	PARAMETER	CONDITIONS	Value		Unit
			B	D	
$I_{T(RMS)}$	On-state Current	180° Conduction Angle, $T_c = 110^\circ C$	12		A
$I_{T(AV)}$	Average On-state Current	Half Cycle, $\Theta = 180^\circ$, $T_c = 110^\circ C$	8		A
I_{TSM}	Non-repetitive On-State Current	Half Cycle, 60 Hz	146		A
I_{TSM}	Non-repetitive On-State Current	Half Cycle, 50 Hz	140		A
I^2t	Fusing Current	$t_p = 10ms$, Half Cycle	98		A^2s
I_{GM}	Peak Gate Current	20 μs max.	4		A
P_{GM}	Peak Gate Dissipation	20 μs max.	10		W
$P_{G(AV)}$	Gate Dissipation	20ms max.	1		W
T_j	Operating Temperature		(-40 to +125)		$^\circ C$
T_{stg}	Storage Temperature		(-40 to +150)		$^\circ C$
T_{sld}	Soldering Temperature	10s max.	260		$^\circ C$
V_{RGM}	Reverse Gate Voltage		5		V
V_{iso}	R.M.S. isolation voltage 50/60 Hz sinusoidal waveform		2.500		Vac

SYMBOL	PARAMETER	CONDITIONS	VOLTAGE					Unit
			B	D	M	S	N	
V_{DRM}	Repetitive Peak Off State Voltage	$R_{GK} = 1 k\Omega$	200	400	600	700	800	V
V_{RRM}								

STANDARD SCR
Electrical Characteristics

SYMBOL	PARAMETER	CONDITIONS	SENSITIVITY		Uni
			09		
I_{GT}	Gate Trigger Current	$V_D = 12 \text{ V}_{DC}, R_L = 140\Omega, T_j = 25^\circ\text{C}$	MIN MAX	2 15	m A
V_{GT}	Gate Trigger Voltage	$V_D = 12 \text{ V}_{DC}, R_L = 140\Omega, T_j = 25^\circ\text{C}$	MAX	1.3	V
V_{GD}	Gate Non Trigger Voltage	$V_D = V_{DRM}, R_L = 3.3k\Omega, R_{GK} = 220\Omega, T_j = 125^\circ\text{C}$	MIN	0.2	V
I_H	Holding Current	$I_T = 500 \text{ mA}$	MAX	20	mA
I_L	Latching Current	$I_G = 1.2 I_{GT}$	MAX	40	mA
dV / dt	Critical Rate of Voltage Rise	$V_D = 0.67 \times V_{DRM}, \text{ Gate open } T_j = 125^\circ\text{C}$	MIN	200	V/ μ s
di / dt	Critical Rate of Current Rise	$I_G = 2 \times I_{GT}, t_r \leq 100 \text{ ns}, f = 60 \text{ Hz}, T_j = 125^\circ\text{C}$	MIN	50	A/ μ s
V_{TM}	On-state Voltage	at $I_T = 24 \text{ Amp}, t_p = 380 \mu\text{s}, T_j = 25^\circ\text{C}$	MAX	1.5	V
$V_{t(o)}$	Threshold Voltage	$T_j = 125^\circ\text{C}$	MAX	0.80	V
r_d	Dynamic resistance	$T_j = 125^\circ\text{C}$	MAX	30	$\text{m}\Omega$
I_{DRM} / I_{RRM}	Off-State Leakage Current	$V_D = V_{DRM}, R_{GK} = 1k\Omega \quad \quad T_j = 125^\circ\text{C}$ $V_R = V_{RRM}, \quad \quad T_j = 25^\circ\text{C}$	MAX MAX	0.5 5	mA μ A
$R_{th(j-c)}$	Thermal Resistance Junction-Case for DC	for AC 360 ° conduction angle		2.9	°C/W
$R_{th(j-a)}$	Thermal Resistance Junction-Amb for DC	$S = 1 \text{ cm}^2$		50	°C/W

PART NUMBER INFORMATION


STANDARD SCR

Fig. 1: Maximum average power dissipation versus average on-state current.

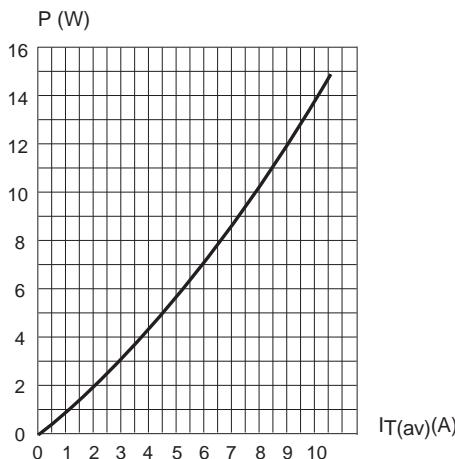


Fig. 3: Relative variation of thermal impedance junction to case versus pulse duration.

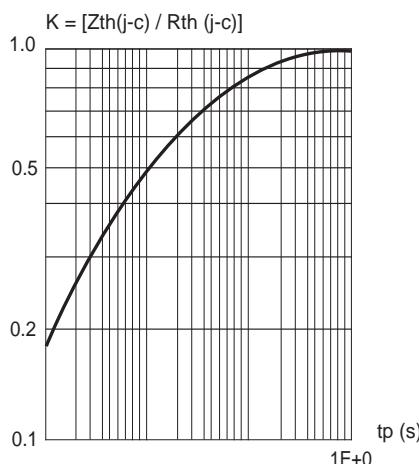


Fig. 5: Non repetitive surge peak on-state current versus number of cycles.

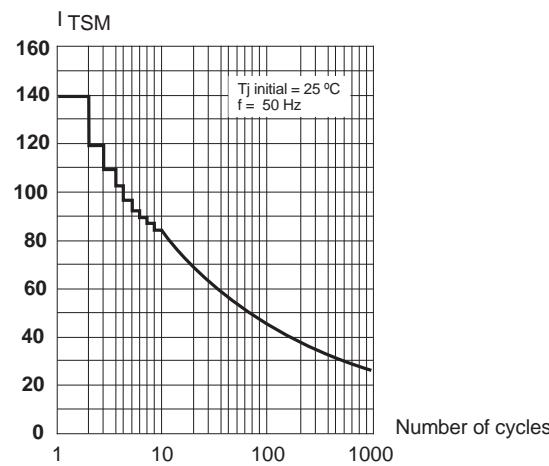


Fig. 2: Average and D.C. on-state current versus case temperature.

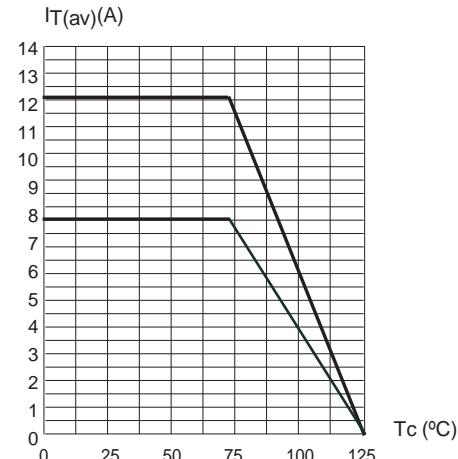


Fig. 4: Relative variation of gate trigger current, holding and latching current versus junction temperature.

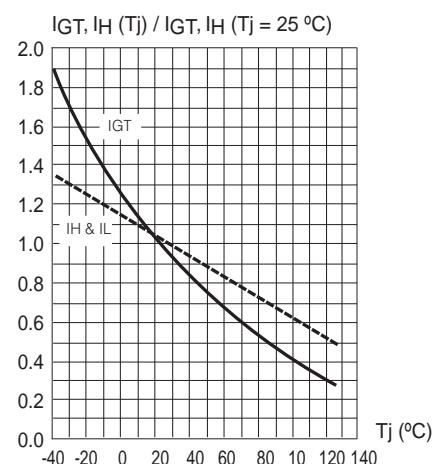
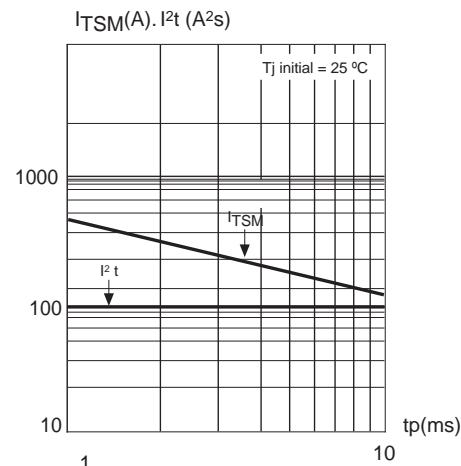
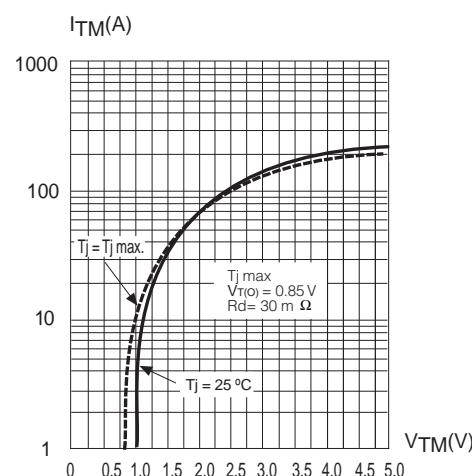


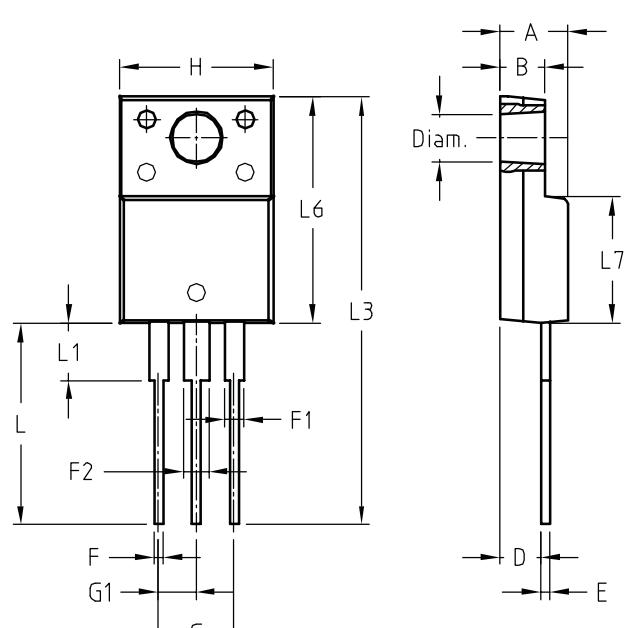
Fig. 6: Non repetitive surge peak on-state current for a sinusoidal pulse with width: $t_p < 10$ ms, and corresponding value of $I^2 t$.



STANDARD SCR

Fig. 7: On-state characteristics (maximum values).


PACKAGE MECHANICAL DATA TO220-F



REF.	DIMENSIONS		
	Milimeters		
	Min.	Nominal	Max.
A	3.55	4.50	4.90
B	2.34	3.00	3.70
D	2.03	2.70	2.96
E	0.35	0.60	0.70
F	0.25	0.60	1.01
F1	0.70	1.30	1.78
F2	0.70	1.70	1.78
G	4.88	5.00	5.28
G1	2.34	2.50	2.74
H	9.65	10.15	10.67
L	12.70	13.35	14.73
L1	2.93	3.75	6.35
L3	26.90	28.35	31.20
L6	14.22	15.00	16.50
L7	8.30	8.40	9.59
Diam.	3.00	3.20	3.28